MOSFET – N-Channel, SUPERFET II, FRFET

600 V, 52 A, 72 m Ω

FCH072N60F-F085

Description

SUPERFET[®] II MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently SUPERFETII is very well suited for the Soft switching and Hard Switching topologies like High Voltage Full Bridge and Half Bridge DC-DC, Interleaved Boost PFC, Boost PFC for HEV-EV automotive. SUPERFET II FRFET[®] MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.

Features

- Typical $R_{DS(on)} = 62 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 26 \text{ A}$
- Typical $Q_{g(tot)} = 160 \text{ nC}$ at $V_{GS} = 10 \text{ V}$, $I_D = 26 \text{ A}$
- UIS Capability
- Qualified to AEC Q101 and PPAP Capable
- This Device is Pb-Free and is RoHS Compliant

Applications

- Automotive On Board Charger
- Automotive DC/DC Converter for HEV



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V _{DSS}	R _{DS(ON)} MAX	I _D MAX
600 V	72 mΩ	52 A



N-Channel MOSFET



MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

MAXIMUM RATINGS ($T_C = 25^{\circ}C$, unless otherwise specified)			
Symbol	Parameter		

Symbol	Parameter		Ratings	Unit
V _{DSS}	Drain to Source Voltage		600	V
V _{GS}	Gate to Source Voltage		±20	V
Ι _D	Drain Current – Continuous (V _{GS} = 10) (Note 1)	T _C = 25°C T _C = 100°C	52 33	A
	Pulsed Drain Current		See Fig. 4	
E _{AS}	Single Pulsed Avalanche Rating (Note 2)		1128	mJ
dv/dt	MOSFET dv/dt		100	V/ns
	Peak Diode Recovery dv/dt (Note 3)		50	
PD	Power Dissipation		481	W
	Derate Above 25°C		3.85	W/°C
T _J , T _{STG}	Operating and Storage Temperature (Note 4)		-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Current is limited by bondwire configuration.

 Current is limited by bondwire comparation.
Starting T_J = 25°C, L = 25 mH, I_{AS} = 9.5 A, V_{DD} = 100 V during inductor charging and V_{DD} = 0 V during time in avalanche.
I_{SD} ≤ 26 A, di/dt ≤ 200 A/μs, V_{DD} ≤ 380 V, starting T_J = 25°C.
R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design, while R_{θJA} is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
R _{θJC}	Thermal Resistance, Junction to Case, Max.	0.26	°C/W
R _{0JA}	Thermal Resistance, Junction to Ambient, Max. (Note 4)	40	

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Reel Size	Tape Width	Quantity
FCH072N60F-F085	FCH072N60F	TO-247-3LD	-	-	30

FI FCTRICAL CHARACTERISTICS ($T_c = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
FF CHARAC	TERISTICS	•			•	
BV _{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \ \mu\text{A}$	600	-	-	V
I _{DSS}	Drain to Source Leakage Current	V_{DS} = 600 V, V_{GS} = 0 V, T_{J} = 25°C	-	-	10	μΑ
		V_{DS} = 600 V, V_{GS} = 0 V, T_{J} = 150°C (Note 5)	_	-	1	mA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}$	-	-	±100	nA
N CHARACT	ERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS}=V_{DS},\ I_{D}=250\ \mu A$	3.0	4.0	5.0	V
r _{DS(on)}	Drain to Source On Resistance	V_{GS} = 10 V, I _D = 26 A, T _J = 25°C	-	62	72	mΩ
		V_{GS} = 10 V, I _D = 26 A, T _J = 150°C (Note 5)	-	154	195	mΩ
YNAMIC CH	ARACTERISTICS					-
C _{iss}	Input Capacitance	V _{DS} = 100 V, V _{GS} = 0 V, f = 1 MHz	-	6330	-	pF
C _{oss}	Output Capacitance		-	199	-	pF
C _{rss}	Reverse Transfer Capacitance		-	1.25	-	pF
Rg	Gate Resistance	f = 1 MHz	-	0.46	-	Ω
Q _{g(TOT)}	Total Gate Charge	V_{DD} = 380 V, I _D = 26 A, V _{GS} = 10 V	-	160	210	nC
Q _{g(th)}	Threshold Gate Charge	1	-	11	16	nC
Q _{gs}	Gate to Source Gate Charge	1	-	34	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	67	-	nC
	CHARACTERISTICS					
t _{on}	Turn-On Time	$V_{DD} = 380 \text{ V}, \text{ I}_{D} = 26 \text{ A},$	-	75	100	ns
t _{d(on)}	Turn-On Delay Time	$V_{GS} = 10$ V, $R_{G} = 4.7 \Omega$	-	44	-	ns
t _r	Rise Time	-	-	31	-	ns
t _{d(off)}	Turn-Off Delay Time		-	128	-	ns
t _f	Fall Time		-	22	-	ns
t _{off}	Turn-Off Time]	-	150	200	ns
RAIN-SOUR	CE DIODE CHARACTERISTICS					
				I	4.0	

V _{SD}	Source to Drain Diode Voltage	I_{SD} = 26 A, V_{GS} = 0 V	-	-	1.2	V
T _{rr}	Reverse Recovery Time	$I_F = 26 \text{ A}, dI_{SD}/dt = 100 \text{ A}/\mu \text{s}$	-	185	-	ns
Q _{rr}	Reverse Recovery Charge	v _{DD} = 480 v	-	1515	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. The maximum value is specified by design at $T_J = 150^{\circ}$ C. Product is not tested to this condition in production.

TYPICAL CHARACTERISTICS







Figure 2. Maximum Continuous Drain Current vs. Case Temperature



Figure 3. Normalized Maximum Transient Thermal Impedance



Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS (continued)



Figure 5. Forward Bias Safe Operating Area







Figure 7. Forward Diode Characteristics







TYPICAL CHARACTERISTICS (continued)



Figure 11. Normalized R_{DSON} vs. Junction Temperature



Figure 12. Normalized Gate Threshold Voltage vs. Temperature



Figure 13. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature





' Voltage



Figure 16. Eoss vs. Drain to Source Voltage



Figure 17. Gate Charge Test Circuit & Waveform



Figure 18. Resistive Switching Test Circuit & Waveforms



Figure 19. Unclamped Inductive Switching Test Circuit & Waveforms



Figure 20. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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